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| INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Not for submission under 37 CFR 1.99) | Application Number | 10/556,482 |
| | Confirmation Number | 1225 |
| | Filing Date | December 14, 2006 |
| | First Named Inventor | Kemal AJAY |
| | Art Unit | 2857 |
| | Examiner Name | Felix E SUAREZ |
| | Attorney Docket Number | Q91512 |

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| EXAMINER SIGNATURE | | | |
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